

 <p style="text-align: center;">FORM HDP-1449 (Based on Form PTO-1449)</p> <p style="text-align: center;">PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)</p> <p style="text-align: center;">Sheet 1 of 4</p>	ATTORNEY DOCKET No.	SERIAL No.
	1740-000040/US	10/762,538
	APPLICANT	
	Sang Woon SUH et al.	
	FILING DATE	GROUP
January 23, 2004	2627	

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		5,572,507	11/05/1996	Ozaki et al.		
2.		5,689,486	11/18/1997	Shimizu et al.		
3.		5,737,286	04/07/1998	Timmermans et al.		
4.		5,799,501	09/01/1998	Leonard et al.		
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7.		6,353,890 B1	03/05/2002	Newman		
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22.		EP 0 299 573 B1	01/18/1989	Europe		N/A	
23.		EP 0 807 929 A1	11/19/1997	Europe		N/A	

Examiner:

Date Considered:

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FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 2 of 4	ATTORNEY DOCKET No.	SERIAL No.
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27.		EP 1 152 412 A1	11/07/2001	Europe		N/A	
28.		EP 1 168 312 A1	01/02/2002	Europe		N/A	
29.		EP 1 229 537 A2	08/07/2002	Europe		N/A	
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64.		U.S. Office Action dated April 17, 2007 for U.S. Application No. 10/762,538
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77.	European Patent Office Action dated March 12, 2008 for European Application No. 04703529.0
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79.	Japanese Patent Office Action dated March 24, 2008 for Japanese Application No. 2006-500637
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